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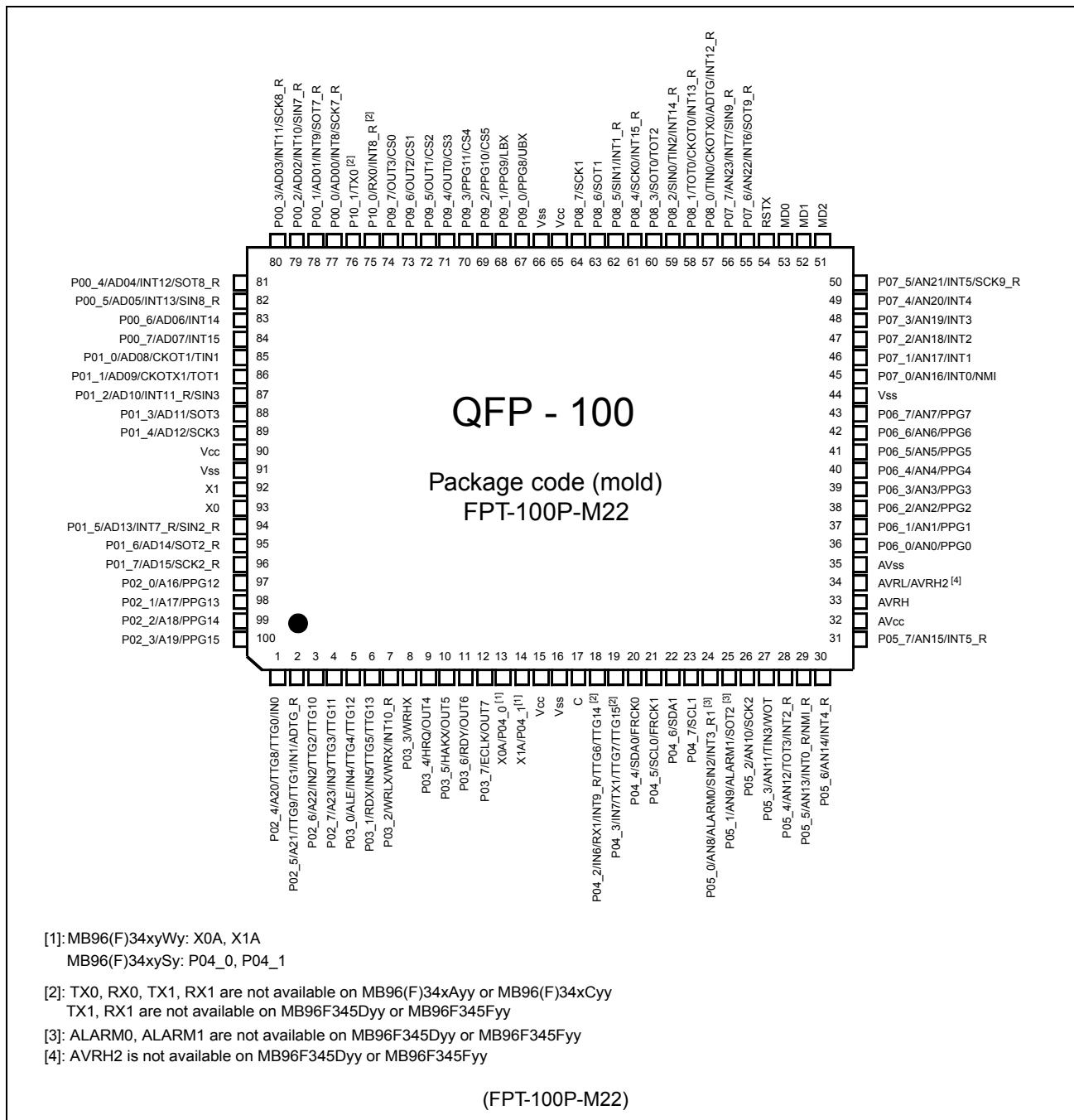
Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Discontinued at Digi-Key
Core Processor	F ² MC-16FX
Core Size	16-Bit
Speed	56MHz
Connectivity	CANbus, EBI/EMI, I ² C, LINbus, SCI, UART/USART
Peripherals	DMA, LVD, LVR, POR, PWM, WDT
Number of I/O	82
Program Memory Size	288KB (288K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 24x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/mb96f346rsbpmc-gse2

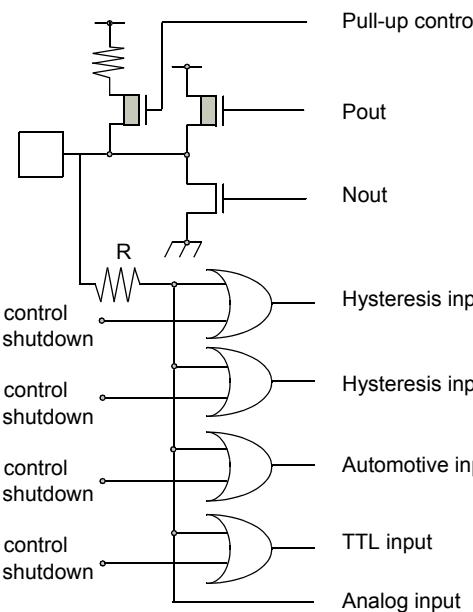
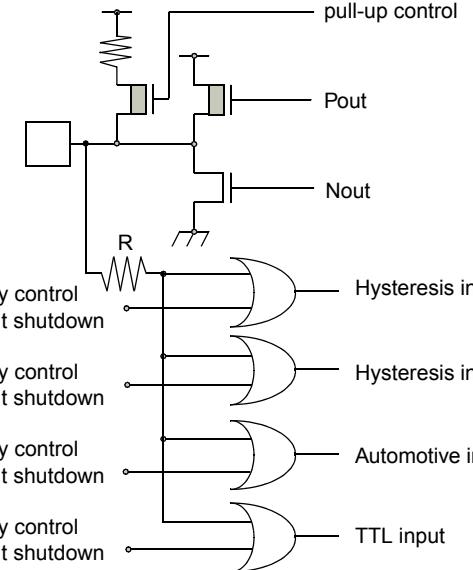
3. Pin Assignments

Figure 2. Pin assignment of MB96(F)34x (FPT-100P-M22)



Remark:

MB96(F)34x products are pin-compatible to F²MC-16LX family MB90340 series.

Type	Circuit	Remarks
I	 <p>Pull-up control Pout Nout Hysteresis input Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Automotive input TTL input Analog input</p>	<ul style="list-style-type: none"> ■ CMOS level output (programmable $I_{OL} = 5\text{mA}$, $I_{OH} = -5\text{mA}$ and $I_{OL} = 2\text{mA}$, $I_{OH} = -2\text{mA}$) ■ 2 different CMOS hysteresis inputs with input shutdown function * ■ Automotive input with input shutdown function ■ TTL input with input shutdown function * ■ Programmable pull-up resistor: $50\text{k}\Omega$ approx. ■ Analog input <p>*MB96F345Dyy or MB96F345Fyy: Only Automotive input and CMOS hysteresis input (0.7/0.3) are supported</p>
N	 <p>pull-up control Pout Nout Hysteresis input Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Automotive input TTL input</p>	<ul style="list-style-type: none"> ■ CMOS level output ($I_{OL} = 3\text{mA}$, $I_{OH} = -3\text{mA}$) ■ 2 different CMOS hysteresis inputs with input shutdown function * ■ Automotive input with input shutdown function ■ TTL input with input shutdown function * ■ Programmable pull-up resistor: $50\text{k}\Omega$ approx. <p>*MB96F345Dyy or MB96F345Fyy: Only Automotive input and CMOS hysteresis input (0.7/0.3) are supported</p>

■ RAM Start/End and External Bus End Addresses

Devices	Bank 0 RAM size	Bank 1 RAM size	External Bus end address	RAMSTART0	RAMSTART1	RAMEND1
MB96(F)345	8KByte	-	00:21FF _H	00:6240 _H	-	-
MB96(F)346, MB96F347	16KByte	-	00:21FF _H	00:4240 _H	-	-
MB96F348	24KByte	-	00:21FF _H	00:2240 _H	-	-

10. Serial Programming Communication Interface

Table 3: USART pins for Flash serial programming (MD[2:0] = 010, Serial Communication mode)

MB96F34x			
Pin number	Pin number	USART Number	Normal function
LQFP-100	QFP-100		
57	59	USART0	SIN0
58	60		SOT0
59	61		SCK0
60	62	USART1	SIN1
61	63		SOT1
62	64		SCK1
22	24	USART2	SIN2
23	25		SOT2
24	26		SCK2
85	87	USART3	SIN3
86	88		SOT3
87	89		SCK3

Note: If a Flash programmer and its software needs to use a handshaking pin, Cypress suggests to the tool vendor to support at least port P00_1 on pin 76/78. If handshaking is used by the tool but P00_1 is not available in customer's application, Cypress suggests to the customer to check the tool manual or to contact the tool vendor for alternative handshaking pins.

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
0000C1 _H	USART0 - Serial Control Register	SCR0		R/W
0000C2 _H	USART0 - TX Register	TDR0		W
0000C2 _H	USART0 - RX Register	RDR0		R
0000C3 _H	USART0 - Serial Status	SSR0		R/W
0000C4 _H	USART0 - Control/Com. Register	ECCR0		R/W
0000C5 _H	USART0 - Ext. Status Register	ESCR0		R/W
0000C6 _H	USART0 - Baud Rate Generator Register Low	BGRL0	BGR0	R/W
0000C7 _H	USART0 - Baud Rate Generator Register High	BGRH0		R/W
0000C8 _H	USART0 - Extended Serial Interrupt Register	ESIR0		R/W
0000C9 _H	Reserved			-
0000CA _H	USART1 - Serial Mode Register	SMR1		R/W
0000CB _H	USART1 - Serial Control Register	SCR1		R/W
0000CC _H	USART1 - TX Register	TDR1		W
0000CC _H	USART1 - RX Register	RDR1		R
0000CD _H	USART1 - Serial Status	SSR1		R/W
0000CE _H	USART1 - Control/Com. Register	ECCR1		R/W
0000CF _H	USART1 - Ext. Status Register	ESCR1		R/W
0000D0 _H	USART1 - Baud Rate Generator Register Low	BGRL1	BGR1	R/W
0000D1 _H	USART1 - Baud Rate Generator Register High	BGRH1		R/W
0000D2 _H	USART1 - Extended Serial Interrupt Register	ESIR1		R/W
0000D3 _H	Reserved			-
0000D4 _H	USART2 - Serial Mode Register	SMR2		R/W
0000D5 _H	USART2 - Serial Control Register	SCR2		R/W
0000D6 _H	USART2 - TX Register	TDR2		W
0000D6 _H	USART2 - RX Register	RDR2		R
0000D7 _H	USART2 - Serial Status	SSR2		R/W
0000D8 _H	USART2 - Control/Com. Register	ECCR2		R/W
0000D9 _H	USART2 - Ext. Status Register	ESCR2		R/W
0000DA _H	USART2 - Baud Rate Generator Register Low	BGRL2	BGR2	R/W
0000DB _H	USART2 - Baud Rate Generator Register High	BGRH2		R/W
0000DC _H	USART2 - Extended Serial Interrupt Register	ESIR2		R/W
0000DD _H	Reserved			-

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
0003D9 _H	Memory Patch function - Patch data 4 High	PFDH4		R/W
0003DA _H	Memory Patch function - Patch data 5 Low	PFDL5	PFD5	R/W
0003DB _H	Memory Patch function - Patch data 5 High	PFDH5		R/W
0003DC _H	Memory Patch function - Patch data 6 Low	PFDL6	PFD6	R/W
0003DD _H	Memory Patch function - Patch data 6 High	PFDH6		R/W
0003DE _H	Memory Patch function - Patch data 7 Low	PFDL7	PFD7	R/W
0003DF _H	Memory Patch function - Patch data 7 High	PFDH7		R/W
0003E0 _H	Data Flash Control and Status register A	DFCSA		R/W
0003E1 _H	Data Flash Write command sequencer Control register A	DFWCA		R/W
0003E2 _H	Data Flash Write command sequencer Status register A	DFWSA		R/W
0003E3 _H -0003F0 _H	Reserved			-
0003F1 _H	Memory Control Status Register A	MCSRA		R/W
0003F2 _H	Memory Timing Configuration Register A Low	MTCRAL	MTCRA	R/W
0003F3 _H	Memory Timing Configuration Register A High	MTCRAH		R/W
0003F4 _H	Reserved			-
0003F5 _H	Memory Control Status Register B	MCSR B		R/W
0003F6 _H	Memory Timing Configuration Register B Low	MTCRBL	MTCRB	R/W
0003F7 _H	Memory Timing Configuration Register B High	MTCRBH		R/W
0003F8 _H	Flash Memory Write Control register 0	FMWC0		R/W
0003F9 _H	Flash Memory Write Control register 1	FMWC1		R/W
0003FA _H	Flash Memory Write Control register 2	FMWC2		R/W
0003FB _H	Flash Memory Write Control register 3	FMWC3		R/W
0003FC _H	Flash Memory Write Control register 4	FMWC4		R/W
0003FD _H	Flash Memory Write Control register 5	FMWC5		R/W
0003FE _H -0003FF _H	Reserved			-
000400 _H	Standby Mode control register	SMCR		R/W
000401 _H	Clock select register	CKSR		R/W
000402 _H	Clock Stabilization select register	CKSSR		R/W
000403 _H	Clock monitor register	CKMR		R
000404 _H	Clock Frequency control register Low	CKFCRL	CKFCR	R/W
000405 _H	Clock Frequency control register High	CKFCRH		R/W
000406 _H	PLL Control register Low	PLLCRL	PLLCR	R/W

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
0005AD _H	PPG14 - Timer register			R
0005AE _H	PPG14 - Period setting register		PCSR14	W
0005AF _H	PPG14 - Period setting register			W
0005B0 _H	PPG14 - Duty cycle register		PDUT14	W
0005B1 _H	PPG14 - Duty cycle register			W
0005B2 _H	PPG14 - Control status register Low	PCNL14	PCN14	R/W
0005B3 _H	PPG14 - Control status register High	PCNH14		R/W
0005B4 _H	PPG15 - Timer register		PTMR15	R
0005B5 _H	PPG15 - Timer register			R
0005B6 _H	PPG15 - Period setting register		PCSR15	W
0005B7 _H	PPG15 - Period setting register			W
0005B8 _H	PPG15 - Duty cycle register		PDUT15	W
0005B9 _H	PPG15 - Duty cycle register			W
0005BA _H	PPG15 - Control status register Low	PCNL15	PCN15	R/W
0005BB _H	PPG15 - Control status register High	PCNH15		R/W
0005BC _H -00065F _H	Reserved			-
000660 _H	Peripheral Resource Relocation Register 10	PRRR10		R/W
000661 _H	Peripheral Resource Relocation Register 11	PRRR11		R/W
000662 _H	Peripheral Resource Relocation Register 12	PRRR12		R/W
000663 _H	Peripheral Resource Relocation Register 13	PRRR13		W
000664 _H -0006DF _H	Reserved			-
0006E0 _H	External Bus - Area configuration register 0 Low	EACL0	EAC0	R/W
0006E1 _H	External Bus - Area configuration register 0 High	EACH0		R/W
0006E2 _H	External Bus - Area configuration register 1 Low	EACL1	EAC1	R/W
0006E3 _H	External Bus - Area configuration register 1 High	EACH1		R/W
0006E4 _H	External Bus - Area configuration register 2 Low	EACL2	EAC2	R/W
0006E5 _H	External Bus - Area configuration register 2 High	EACH2		R/W
0006E6 _H	External Bus - Area configuration register 3 Low	EACL3	EAC3	R/W
0006E7 _H	External Bus - Area configuration register 3 High	EACH3		R/W
0006E8 _H	External Bus - Area configuration register 4 Low	EACL4	EAC4	R/W
0006E9 _H	External Bus - Area configuration register 4 High	EACH4		R/W
0006EA _H	External Bus - Area configuration register 5 Low	EACL5	EAC5	R/W

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
0006EB _H	External Bus - Area configuration register 5 High	EACH5		R/W
0006EC _H	External Bus - Area select register 2	EAS2		R/W
0006ED _H	External Bus - Area select register 3	EAS3		R/W
0006EE _H	External Bus - Area select register 4	EAS4		R/W
0006EF _H	External Bus - Area select register 5	EAS5		R/W
0006F0 _H	External Bus - Mode register	EBM		R/W
0006F1 _H	External Bus - Clock and Function register	EBCF		R/W
0006F2 _H	External Bus - Address output enable register 0	EBAE0		R/W
0006F3 _H	External Bus - Address output enable register 1	EBAE1		R/W
0006F4 _H	External Bus - Address output enable register 2	EBAE2		R/W
0006F5 _H	External Bus - Control signal register	EBCS		R/W
0006F6 _H -0006FF _H	Reserved			-
000700 _H	CAN0 - Control register Low	CTRLRL0	CTRLR0	R/W
000701 _H	CAN0 - Control register High (reserved)	CTRLRH0		R
000702 _H	CAN0 - Status register Low	STATRL0	STATR0	R/W
000703 _H	CAN0 - Status register High (reserved)	STATRH0		R
000704 _H	CAN0 - Error Counter Low (Transmit)	ERRCNTL0	ERRCNT0	R
000705 _H	CAN0 - Error Counter High (Receive)	ERRCNTH0		R
000706 _H	CAN0 - Bit Timing Register Low	BTRL0	BTR0	R/W
000707 _H	CAN0 - Bit Timing Register High	BTRH0		R/W
000708 _H	CAN0 - Interrupt Register Low	INTRL0	INTR0	R
000709 _H	CAN0 - Interrupt Register High	INTRH0		R
00070A _H	CAN0 - Test Register Low	TESTRL0	TESTR0	R/W
00070B _H	CAN0 - Test Register High (reserved)	TESTRH0		R
00070C _H	CAN0 - BRP Extension register Low	BRPERL0	BRPER0	R/W
00070D _H	CAN0 - BRP Extension register High (reserved)	BRPERH0		R
00070E _H -00070F _H	Reserved			-
000710 _H	CAN0 - IF1 Command request register Low	IF1CREQL0	IF1REQ0	R/W
000711 _H	CAN0 - IF1 Command request register High	IF1CREQH0		R/W
000712 _H	CAN0 - IF1 Command Mask register Low	IF1CMSKL0	IF1CMSK0	R/W
000713 _H	CAN0 - IF1 Command Mask register High (reserved)	IF1CMSKH0		R
000714 _H	CAN0 - IF1 Mask 1 Register Low	IF1MSK1L0	IF1MSK10	R/W

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
000884 _H -00088F _H	Reserved			-
000890 _H	CAN1 - New Data 1 Register Low	NEWDT1L1	NEWDT11	R
000891 _H	CAN1 - New Data 1 Register High	NEWDT1H1		R
000892 _H	CAN1 - New Data 2 Register Low	NEWDT2L1	NEWDT21	R
000893 _H	CAN1 - New Data 2 Register High	NEWDT2H1		R
000894 _H -00089F _H	Reserved			-
0008A0 _H	CAN1 - Interrupt Pending 1 Register Low	INTPND1L1	INTPND11	R
0008A1 _H	CAN1 - Interrupt Pending 1 Register High	INTPND1H1		R
0008A2 _H	CAN1 - Interrupt Pending 2 Register Low	INTPND2L1	INTPND21	R
0008A3 _H	CAN1 - Interrupt Pending 2 Register High	INTPND2H1		R
0008A4 _H -0008AF _H	Reserved			-
0008B0 _H	CAN1 - Message Valid 1 Register Low	MSGVAL1L1	MSGVAL11	R
0008B1 _H	CAN1 - Message Valid 1 Register High	MSGVAL1H1		R
0008B2 _H	CAN1 - Message Valid 2 Register Low	MSGVAL2L1	MSGVAL21	R
0008B3 _H	CAN1 - Message Valid 2 Register High	MSGVAL2H1		R
0008B4 _H -0008CD _H	Reserved			-
0008CE _H	CAN1 - Output enable register	COER1		R/W
0008CF _H -0009FF _H	Reserved			-
000A00 _H	DMA - IO address block register 0	IOABK0		R/W
000A01 _H	DMA - IO address block register 1	IOABK1		R/W
000A02 _H	DMA - IO address block register 2	IOABK2		R/W
000A03 _H	DMA - IO address block register 3	IOABK3		R/W
000A04 _H	DMA - IO address block register 4	IOABK4		R/W
000A05 _H	DMA - IO address block register 5	IOABK5		R/W
000A06 _H -000BFF _H	Reserved			-

Note: Any write access to reserved addresses in the I/O map should not be performed. A read access to a reserved address results in reading 'X'. Registers of resources which are described in this table, but which are not supported by the device, should also be handled as "Reserved".

[4]: The maximum permitted power dissipation depends on the ambient temperature, the air flow velocity and the thermal conductance of the package on the PCB. The actual power dissipation depends on the customer application and can be calculated as follows:

$$P_D = P_{IO} + P_{INT}$$

$P_{IO} = \sum (V_{OL} * I_{OL} + V_{OH} * I_{OH})$ (IO load power dissipation, sum is performed on all IO ports)

$P_{INT} = V_{CC} * (I_{CC} + I_A)$ (internal power dissipation)

I_{CC} is the total core current consumption into V_{CC} as described in the "DC characteristics" and depends on the selected operation mode and clock frequency and the usage of functions like Flash programming or the clock modulator. I_A is the analog current consumption into AV_{CC} .

[5]: Worst case value for a package mounted on single layer PCB at specified T_A without air flow.

[6]: Please contact Cypress for reliability limitations when using under these conditions.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed any of these ratings.

14.2 Recommended Operating Conditions

Parameter	Symbol	Value			Unit	Remarks
		Min	Typ	Max		
Power supply voltage	V_{CC}	3.0	-	5.5	V	
Smoothing capacitor at C pin	C_S	3.5	4.7 - 10	15	μF	Use a low inductance capacitor (for example X7R ceramic capacitor)

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

$(T_A = -40^\circ\text{C} \text{ to } 125^\circ\text{C}, V_{CC} = AV_{CC} = 3.0\text{V} \text{ to } 5.5\text{V}, V_{SS} = AV_{SS} = 0\text{V})$

Parameter	Symbol	Condition (at T_A)	Value			Remarks	
			Typ	Max	Unit		
Power supply current in Timer modes ^[1]	I_{CCTRCL}	RC Timer mode with $\text{CLKRC} = 100\text{kHz}$, $\text{SMCR:LPMSS} = 0$ (CLKMC, CLKPLL and CLKSC stopped. Voltage regulator in high power mode)	+25°C	0.3	0.45	mA	MB96F346/F347/F348
			+125°C	0.8	3.2		
			+25°C	0.08	0.15	mA	MB96F345
			+125°C	0.58	2.95		
		RC Timer mode with $\text{CLKRC} = 100\text{kHz}$, $\text{SMCR:LPMSS} = 1$ (CLKMC, CLKPLL and CLKSC stopped. Voltage regulator in low power mode)	+25°C	0.3	0.45	mA	MB96345/346
			+125°C	0.8	2.2		
			+25°C	0.05	0.1	mA	Flash devices
	I_{CCTSUB}	Sub Timer mode with $\text{CLKSC} = 32\text{kHz}$ (CLKMC, CLKPLL and CLKRC stopped)	+125°C	0.55	2.85		
			+25°C	0.05	0.1	mA	MB96345/346
			+125°C	0.55	1.85		
			+25°C	0.03	0.1	mA	Flash devices
Power supply current in Stop Mode	I_{CCH}	VRCR:LPMB[2:0] = 110 _B (Core voltage at 1.8V)	+125°C	0.52	2.8	mA	Flash devices
			+25°C	0.02	0.08		
			+125°C	0.52	1.8	mA	MB96345/346
		VRCR:LPMB[2:0] = 000 _B (Core voltage at 1.2V)	+25°C	0.015	0.06	mA	Flash devices
			+125°C	0.4	2.3		
			+25°C	0.015	0.06	mA	MB96345/346
			+125°C	0.4	1.4		
Power supply current for active Low Voltage detector	I_{CCLVD}	Low voltage detector enabled (RCR:LVDE = 1)	-	5	10	μA	MB96F345 Must be added to all current above
			+25°C	90	140	μA	Other devices Must be added to all current above
			+125°C	100	150		

($T_A = -40^\circ\text{C}$ to 125°C , $V_{CC} = AV_{CC} = 3.0\text{V}$ to 5.5V , $V_{SS} = AV_{SS} = 0\text{V}$)

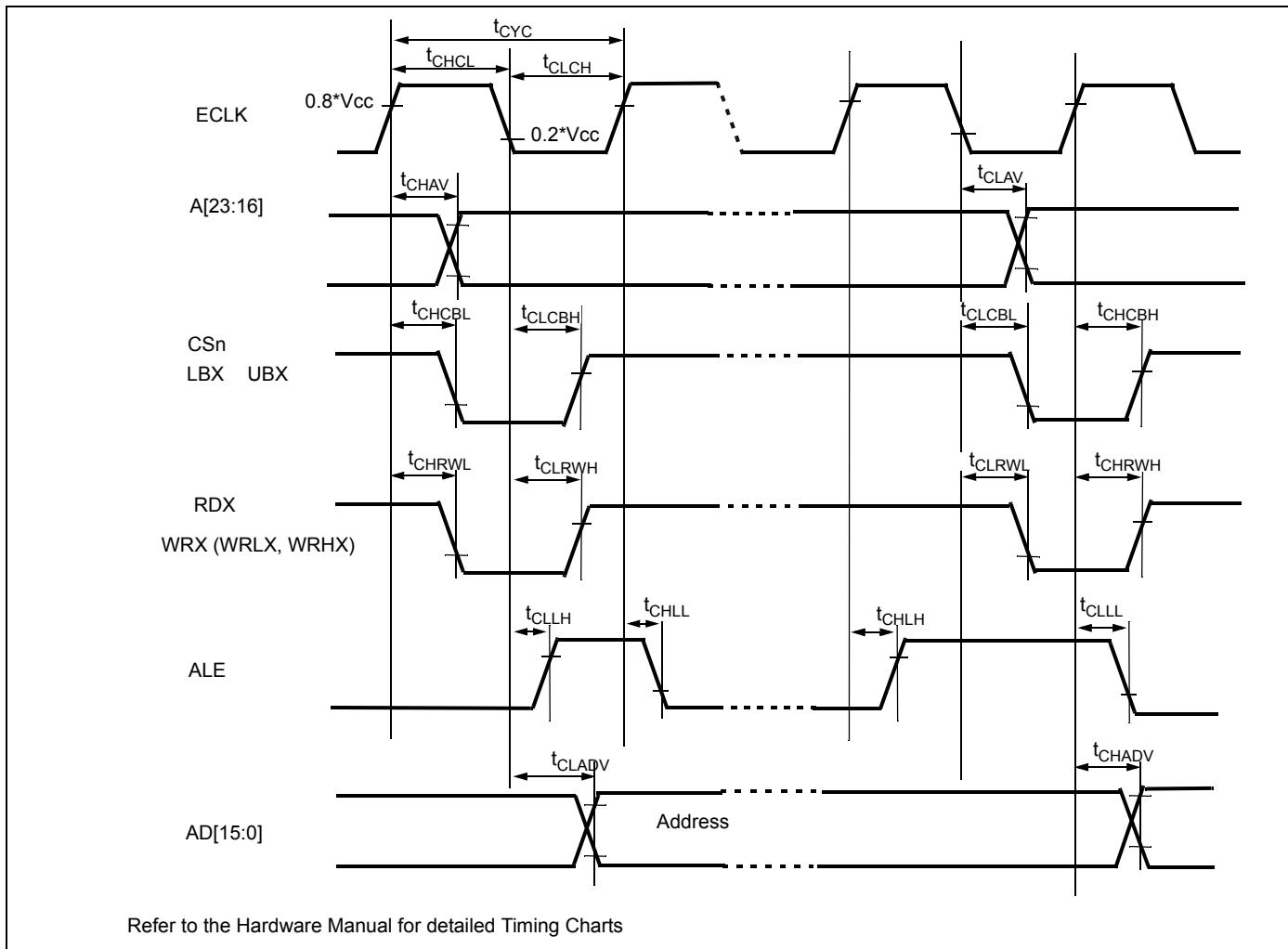
Parameter	Symbol	Condition (at T_A)	Value			Remarks	
			Typ	Max	Unit		
Power supply current for active Clock modulator	$I_{CCCLOMO}$	Clock modulator enabled (CMCR:PDX = 1)	-	3	4.5	mA	Must be added to all current above
Flash Write/Erase current	$I_{CCFLASH}$	Current for one Flash module	-	15	40	mA	Must be added to all current above
	$I_{CCDFLASH}$	Current for one Data Flash module		10	20	mA	Must be added to all current above
Input capacitance	C_{IN}	-	-	5	15	pF	Other than C, AV_{CC} , AV_{SS} , $AVRH$, $AVRL$, V_{CC} , V_{SS}

[1]: The power supply current is measured with a 4MHz external clock connected to the Main oscillator and a 32kHz external clock connected to the Sub oscillator. See chapter "Standby mode and voltage regulator control circuit" of the Hardware Manual for further details about voltage regulator control.

14.4.7 Basic Timing

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = 5.0 \text{ V} \pm 10\%$, $V_{SS} = 0.0 \text{ V}$, $\text{IO}_{\text{drive}} = 5\text{mA}$, $C_L = 50\text{pF}$)

Parameter	Symbol	Pin	Condition	Value		Unit	Remarks
				Min	Max		
ECLK	t_{CYC}	ECLK	-	25	-	ns	
	t_{CHCL}			$t_{CYC}/2-5$	$t_{CYC}/2+5$		
	t_{CLCH}			$t_{CYC}/2-5$	$t_{CYC}/2+5$		
ECLK → UBX/ LBX / CSn time	t_{CHCBH}	CSn, UBX, LBX, ECLK	-	-20	20	ns	
	t_{CHCBL}			-20	20		
	t_{CLCBH}			-20	20		
	t_{CLCBL}			-20	20		
ECLK → ALE time	t_{CHLH}	ALE, ECLK	-	-10	10	ns	
	t_{CHLL}			-10	10		
	t_{CLLH}			-10	10		
	t_{CLLL}			-10	10		
ECLK → address valid time	t_{CHAV}	A[23:16], ECLK	-	-15	15	ns	
	t_{CLAV}			-15	15		
	t_{CLADV}	AD[15:0], ECLK	-	-15	15	ns	
	t_{CHADV}			-15	15		
ECLK → RDX /WRX time	t_{CHRWH}	RDX, WRX, WRLX,WRHX, ECLK	-	-10	10	ns	
	t_{CHRWL}			-10	10		
	t_{CLRWH}			-10	10		
	t_{CLRWL}			-10	10		



14.4.12 USART timing

WARNING: The values given below are for an I/O driving strength $IO_{drive} = 5mA$. If IO_{drive} is $2mA$, all the maximum output timing described in the different tables must then be increased by $10ns$.

($T_A = -40^{\circ}C$ to $125^{\circ}C$, $V_{CC} = 3.0V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $IO_{drive} = 5mA$, $C_L = 50pF$)

Parameter	Symbol	Pin	Condition	$V_{CC} = AV_{CC} = 4.5V$ to $5.5V$		$V_{CC} = AV_{CC} = 3.0V$ to $4.5V$		Unit
				Min	Max	Min	Max	
Serial clock cycle time	t_{SCYCI}	SCKn	Internal Shift Clock Mode	$4 t_{CLKP1}$	-	$4 t_{CLKP1}$	-	ns
SCK $\downarrow \rightarrow$ SOT delay time	t_{SLOVI}	SCKn, SOTn		-20	+20	-30	+30	ns
SOT \rightarrow SCK \uparrow delay time	t_{OVSHI}	SCKn, SOTn		$N*t_{CLKP1} - 20$ [1]	-	$N*t_{CLKP1} - 30$ [1]	-	ns
Valid SIN \rightarrow SCK \uparrow	t_{IVSHI}	SCKn, SINn		$t_{CLKP1} + 45$	-	$t_{CLKP1} + 55$	-	ns
SCK $\uparrow \rightarrow$ Valid SIN hold time	t_{SHIXI}	SCKn, SINn		0	-	0	-	ns
Serial clock "L" pulse width	t_{SLSHE}	SCKn	External Shift Clock Mode	$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
Serial clock "H" pulse width	t_{SHSLE}	SCKn		$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
SCK $\downarrow \rightarrow$ SOT delay time	t_{SLOVE}	SCKn, SOTn		-	$2 t_{CLKP1} + 45$	-	$2 t_{CLKP1} + 55$	ns
Valid SIN \rightarrow SCK \uparrow	t_{IVSHE}	SCKn, SINn		$t_{CLKP1}/2 + 10$	-	$t_{CLKP1}/2 + 10$	-	ns
SCK $\uparrow \rightarrow$ Valid SIN hold time	t_{SHIXE}	SCKn, SINn		$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
SCK fall time	t_{FE}	SCKn		-	20	-	20	ns
SCK rise time	t_{RE}	SCKn		-	20	-	20	ns

Notes:

- AC characteristic in CLK synchronized mode.
- C_L is the load capacity value of pins when testing.
- Depending on the used machine clock frequency, the maximum possible baud rate can be limited by some parameters. These parameters are shown in "MB96300 Super series HARDWARE MANUAL".
- t_{CLKP1} is the cycle time of the peripheral clock 1 (CLKP1), Unit : ns

[1]: Parameter N depends on t_{SCYCI} and can be calculated as follows:

- if $t_{SCYCI} = 2*k*t_{CLKP1}$, then $N = k$, where k is an integer > 2
- if $t_{SCYCI} = (2*k+1)*t_{CLKP1}$, then $N = k+1$, where k is an integer > 1

Examples:

t_{SCYCI}	N
$4*t_{CLKP1}$	2
$5*t_{CLKP1}$,	3
$7*t_{CLKP1}$,	4
...	...

14.6 Alarm Comparator

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = AV_{CC} = 3.0\text{V} - 5.5\text{V}$, $V_{SS} = AV_{SS} = 0\text{V}$)

Parameter	Symbol	Pin	Value			Unit	Remarks
			Min	Typ	Max		
Power supply current	I_{A5ALMF}	AV_{CC}	-	25	45	μA	Alarm comparator enabled in fast mode (one channel)
	I_{A5ALMS}		-	7	13	μA	Alarm comparator enabled in slow mode (one channel)
	I_{A5ALMH}		-	-	5	μA	Alarm comparator disabled
ALARM pin input current	I_{ALIN}	ALARM0, ALARM1	-1	-	+1	μA	$T_A = 25^\circ\text{C}$
ALARM pin input voltage range	V_{ALIN}		-3	-	+3	μA	$T_A = 125^\circ\text{C}$
External low threshold high->low transition	$V_{EVTL(H>L)}$		0	-	AV_{CC}	V	INTREF = 0
External low threshold low->high transition	$V_{EVTL(L>H)}$		0.36 * AV_{CC} -0.25	0.36 * AV_{CC} -0.1	-	V	
External high threshold high->low transition	$V_{EVTH(H>L)}$		-	0.36 * AV_{CC} +0.1	0.36 * AV_{CC} +0.25	V	
External high threshold low->high transition	$V_{EVTH(L>H)}$		0.78 * AV_{CC} -0.25	0.78 * AV_{CC} -0.1	-	V	
Internal low threshold high->low transition	$V_{IVTL(H>L)}$		0.78 * AV_{CC} +0.1	0.78 * AV_{CC} +0.25	-	V	
Internal low threshold low->high transition	$V_{IVTL(L>H)}$		0.9	1.1	-	V	INTREF = 1
Internal high threshold high->low transition	$V_{IVTH(H>L)}$		-	1.3	1.55	V	
Internal high threshold low->high transition	$V_{IVTH(L>H)}$		2.2	2.4	-	V	
Switching hysteresis	V_{HYS}		-	2.6	2.85	V	
Comparison time	t_{COMPF}		50	-	300	mV	
	t_{COMPS}		-	0.1	1	μs	CMD = 1 (fast)
			-	1	10	μs	CMD = 0 (slow)
Power-up stabilization time after enabling alarm comparator	t_{PD}		-	1	5	ms	Threshold levels specified above are not guaranteed within this time
Slow/Fast mode transition time	t_{CMD}		-	100	500	μs	

14.7 Low Voltage Detector Characteristics

(T_A = -40 °C to +125 °C, V_{CC} = AV_{CC} = 3.0V - 5.5V, V_{SS} = AV_{SS} = 0V)

Parameter	Symbol	Value [1]		Value [2]		Unit	Remarks
		Min	Max	Min	Max		
Stabilization time	T _{LVDSTAB}	-	75	-	110	μs	After power-up or change of detection level
Level 0	V _{DL0}	2.7	2.9	2.65	2.95	V	CILCR:LVL[3:0] = "0000"
Level 1	V _{DL1}	2.9	3.1	2.85	3.2	V	CILCR:LVL[3:0] = "0001"
Level 2	V _{DL2}	3.1	3.3	3.05	3.4	V	CILCR:LVL[3:0] = "0010"
Level 3	V _{DL3}	3.5	3.75	3.45	3.85	V	CILCR:LVL[3:0] = "0011"
Level 4	V _{DL4}	3.6	3.85	3.55	3.95	V	CILCR:LVL[3:0] = "0100"
Level 5	V _{DL5}	3.7	3.95	3.65	4.1	V	CILCR:LVL[3:0] = "0101"
Level 6	V _{DL6}	3.8	4.05	3.75	4.2	V	CILCR:LVL[3:0] = "0110"
Level 7	V _{DL7}	3.9	4.15	3.85	4.3	V	CILCR:LVL[3:0] = "0111"
Level 8	V _{DL8}	4.0	4.25	3.95	4.4	V	CILCR:LVL[3:0] = "1000"
Level 9	V _{DL9}	4.1	4.35	4.05	4.5	V	CILCR:LVL[3:0] = "1001"
Level 10	V _{DL10}	not used		not used			
Level 11	V _{DL11}	not used		not used			
Level 12	V _{DL12}	not used		not used			
Level 13	V _{DL13}	not used		not used			
Level 14	V _{DL14}	not used		not used			
Level 15	V _{DL15}	not used		not used			

[1]: valid for all devices except devices listed under "[2]"

[2]: valid for: MB96F345

CILCR:LVL[3:0] are the low voltage detector level select bits of the CILCR register.

Levels 10 to 15 are not used in this device.

For correct detection, the slope of the voltage level must satisfy $\left| \frac{dV}{dt} \right| \leq 0.004 \frac{V}{\mu s}$.

Faster variations are regarded as noise and may not be detected.

The functional operation of the MCU is guaranteed down to the minimum low voltage detection level of V_{CC} = 2.7V. The electrical characteristics however are only valid in the specified range (usually down to 3.0V).

14.8 Flash Memory Program/erase Characteristics

($T_A = -40^\circ\text{C}$ to 105°C , $V_{CC} = AV_{CC} = 3.0\text{V}$ to 5.5V , $V_{SS} = AV_{SS} = 0\text{V}$)

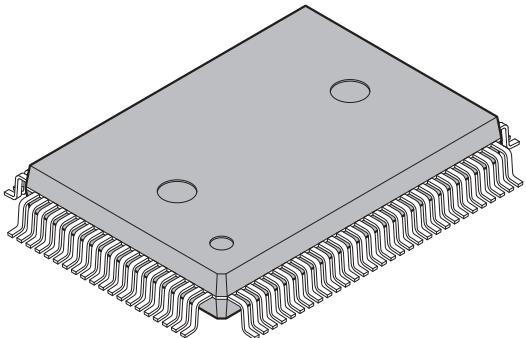
Parameter	Value			Unit	Remarks
	Min	Typ	Max		
Sector erase time Program/Data Flash (Main Flash)	-	0.9	3.6	s	Without erasure pre-programming time
Sector erase time Data Flash	-	0.5	2	s	Without erasure pre-programming time
	-	0.8	3.6	s	Including erasure pre-programming time
Chip erase time Program/Data Flash (Main Flash)	-	$n \times 0.9$	$n \times 3.6$	s	Without erasure pre-programming time (n is the number of Flash sector of the device)
Chip erase time Data Flash	-	2.5	10	s	Without erasure pre-programming time
	-	3.7	16.4	s	Including erasure pre-programming time
Word (16-bit width) programming time Program/Data Flash (Main Flash)	-	23	370	us	Without overhead time for submitting write command
Byte (8-bit width) programming time Data Flash	-	15	100	us	Without overhead time for submitting write command
Program/Erase cycle	10000	-	-	cycle	100 000 Program/Erase cycles are under evaluation by Cypress
Flash data retention time	20	-	-	year	[1]

[1]: This value was converted from the results of evaluating the reliability of the technology (using Arrhenius equation to convert high temperature measurements into normalized value at 85°C)

Table 6: Used settings

Mode	Selected Source Clock	Clock/Regulator Settings
Timer mode	PLL	CLKMC = 4 MHz, CLKPLL = 56 MHz (System clocks are stopped in this mode) Regulator in High Power Mode, Core Voltage = 1.9 V
	Main osc.	CLKMC = 4 MHz (System clocks are stopped in this mode) Regulator in High Power Mode, Core Voltage = 1.8 V
	RC clock fast	CLKRC = 2 MHz (System clocks are stopped in this mode) Regulator in High Power Mode, Core Voltage = 1.8 V
	RC clock slow	CLKRC = 100 kHz (System clocks are stopped in this mode) Regulator in High Power Mode, Core Voltage = 1.8 V
	Sub osc.	CLKSC = 100 kHz (System clocks are stopped in this mode) Regulator in Low Power Mode A, Core Voltage = 1.8 V
Stop mode	stopped	(All clocks are stopped in this mode) Regulator in Low Power Mode B, Core Voltage = 1.8 V

17. Package Dimension MB96(F)34x QFP 100P

100-pin plastic QFP  (FPT-100P-M22)	Lead pitch 0.65 mm
	Package width × package length 14.00 mm × 20.00 mm
	Lead shape Gullwing
	Sealing method Plastic mold
	Mounting height 3.35 mm MAX
	Code (Reference) P-QFP100-14×20-0.65

